



UNIVERSITEIT VAN PRETORIA
UNIVERSITY OF PRETORIA
YUNIBESITHI YA PRETORIA

Contribution ID: 311

Type: **Poster Presentation**

Defect complexes on SiC surfaces

Tuesday, 10 July 2012 17:30 (2 hours)

Abstract content
 (Max 300 words)

SiC is a technologically important material because of its hardness and semi-conducting properties. SiC surfaces are important, for example, as a substrate in the growth of graphene. The epitaxial growth of SiC is important and here the structure of SiC surfaces are relevant. In our work, we study surfaces of SiC using first principles total energy methods. We consider surfaces of the cubic and hexagonal forms of SiC, both Si-terminated and C-terminated. Our primary focus is adatoms and vacancies on these surfaces. We have shown the effect of surface geometry on these defect complexes with the view of determining low energy configurations.

Apply to be
 consider for a student
 award (Yes / No)?

Yes

Level for award
(Hons, MSc,
 PhD)?

MSc

Main supervisor (name and email)
and his / her institution

Prof Nithaya Chetty, nithaya.chetty@up.ac.za, University Of Pretoria

Would you like to
 submit a short paper
 for the Conference
 Proceedings (Yes / No)?

No

Primary author: Ms KHOZA, Eva (University of Pretoria)

Co-author: Prof. CHETTY, Nithaya (University of Pretoria)

Presenter: Ms KHOZA, Eva (University of Pretoria)

Session Classification: Poster Session

Track Classification: Track A - Division for Condensed Matter Physics and Materials